Search Notes				

Application/Control No.	Applicant(s Reexamina
10/790,095	HACHIYA

s)/Patent under

HACHIYA ET AL.

Art Unit

James R. Bidwell

Examiner

3651

SEARCHED			
Class	Subclass	Date	Examiner
198	377		
	469.1		
	470.1		
271	184		
	185		
	204		
	205		
	206		
	225		
Above	Updated	10/3/2005	JRB

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
198	470.1	10/3/2005	JRB	
	1			

	DATE	EXMR
Interference Search History Printout	10/3/2005	JRB